

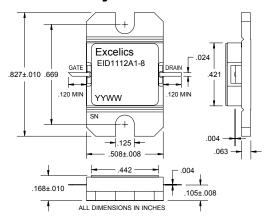
EID1112A1-8

UPDATED 07/12/2007

11.70-12.70 GHz 8-Watt Internally Matched Power FET

FEATURES

- 11.70-12.70 GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +39.5 dBm Output Power at 1dB Compression
- 8.0 dB Power Gain at 1dB Compression
- 35% Power Added Efficiency
- Hermetic Metal Flange Package
- 100% Tested for DC, RF, and R_{TH}





ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Caution! ESD sensitive device.

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$	38.5	39.5		dBm
G _{1dB}	Gain at 1dB Compression $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$	7.0	8.0		dB
ΔG	Gain Flatness $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression V_{DS} = 10 V, $I_{DSQ} \approx 2200$ mA f = 11.70-12.70GHz		35		%
Id _{1dB}	Drain Current at 1dB Compression f = 11.70-12.70GHz		2800	3200	mA
I _{DSS}	Saturated Drain Current V _{DS} = 3 V, V _{GS} = 0 V		4400	5200	mA
V_P	Pinch-off Voltage $V_{DS} = 3 \text{ V}, I_{DS} = 40 \text{ mA}$		-1.2	-2.5	V
R _{TH}	Thermal Resistance ³		3.5	4.0	°C/W

Notes: 1. Tested with 100 Ohm gate resistor.

ABSOLUTE MAXIMUM RATINGS FOR CONTINUOUS OPERATION^{1,2}

SYMBOL	CHARACTERISTIC	VALUE	
V_{DS}	Drain to Source Voltage	10 V	
V_{GS}	Gate to Source Voltage	-3.0 V	
I _{DS}	Drain Current	IDSS	
I _{GSF}	Forward Gate Current	80 mA	
P _{IN}	Input Power	@ 3dB compression	
P_{T}	Total Power Dissipation	32 W	
Тсн	Channel Temperature	150°C	
T _{STG}	Storage Temperature	-65/+150°C	

Note: 1. Exceeding any of the above ratings may result in permanent damage.

^{2.} Overall Rth depends on case mounting.

^{2.} Exceeding any of the above ratings may reduce MTTF below design goals.



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